

VMDSEMI

VFPB004R009NA

Datasheet

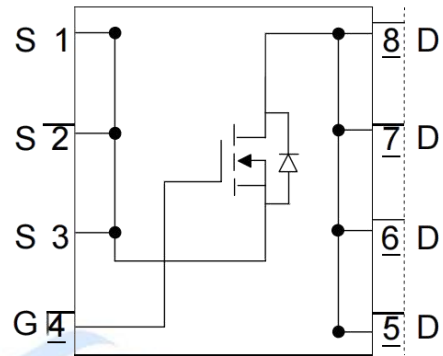


VMDSEMI

0.9mΩ, 40V, N-Channel MOSFET
VFPB004R009NA
Description

- 40V N-channel SGT MOSFET
- It has been designed to very low on-state resistance and superior UIS performance, especial for BMS application
- Untral Low Rdson and Fast reverse recovery for synchronous rectification

$V_{(BR)DSS}$	$R_{DS(ON)_{max}}$	I_D
40V	0.9mΩ@10V	370A

Symbol


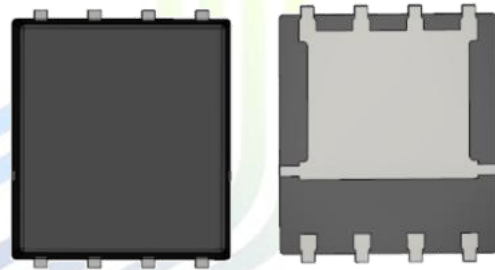
Symbol of VFPB004R009NA

Features

- Low $R_{DS(ON)}$
- Fast reverse recovery
- 100% UIS tested
- Fast switching

Application

- Battery management system
- DC-DC converter
- Synchronous rectification

Package Type


Package Type of VFPB004R009NA

Ordering Information

Product Name	Package
VFPB004R009NA	PDFN5×6

Absolute Maximum Ratings ($T_J = 25\text{ °C}$, unless otherwise specified)

Parameter	Symbol	Value	Units
Drain-Source Voltage	V_{DS}	40	V
Drain Current - Continuous ($T_C = 25\text{ °C}$ $V_{GS} = 10\text{ V}$) ^{Note 1}	I_D	370	A
Drain Current - Continuous ($T_C = 100\text{ °C}$ $V_{GS} = 10\text{ V}$)		220	A
Drain Current - Pulsed ^{Note 2}	I_{DM}	900	A
Gate-Source Voltage	V_{GS}	± 20	V
Single Pulsed Avalanche Energy ^{Note 3}	E_{AS}	550	mJ
Repetitive Avalanche Energy ^{Note 3}	E_{AR}	0.2	mJ
Power Dissipation ($T_C = 25\text{ °C}$)	P_D	125	W
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C

Thermal Resistance

Parameter	Symbol	Value	Units
Thermal Resistance, Junction-to-Case, Steady-State	$R_{\theta JC}$	1.0	°C/W
Thermal Resistance, Junction-to-Ambient, Steady State ^{Note 4}	$R_{\theta JA}$	54	°C/W

Notes:

1. The max drain current rating is package limited
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $L = 0.5\text{ mH}$, $V_{DD} = 30\text{ V}$, $R_g = 10\ \Omega$, Starting $T_J = 25\text{ °C}$
4. Mount on minimum PCB layout

Electrical Characteristics($T_J = 25\text{ }^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Static Characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	40	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$	-	-	10	μA
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$	-	-	± 100	nA
Gate Threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	1.2	1.6	2	V
Drain-Source on-state resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$	-	0.6	0.9	mΩ
		$V_{GS} = 5\text{ V}, I_D = 30\text{ A}$	-	0.9	1.2	mΩ
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	-	7020	-	pF
Output Capacitance	C_{oss}		-	2435	-	pF
Reverse Transfer Capacitance	C_{rss}		-	50	-	pF
Gate Resistance	R_g	$f = 1\text{ MHz}$	-	2	-	Ω
Switching Characteristics						
Turn On Delay Time	$T_{D(on)}$	$V_{DD} = 32\text{ V}, I_D = 50\text{ A}$ $V_{GS} = 10\text{ V}, R_G = 2.5\text{ }\Omega$	-	12	-	ns
Rise Time	T_r		-	41	-	ns
Turn Off Delay Time	$T_{D(off)}$		-	29	-	ns
Fall Time	T_f		-	65	-	ns
Total Gate Charge	Q_g	$V_{DD} = 20\text{ V}, I_D = 50\text{ A}$ $V_{GS} = 0\text{ to }10\text{ V}$	-	92	-	nC
Gate-Source Charge	Q_{gs}		-	19	-	nC
Gate-Drain Charge	Q_{gd}		-	9	-	nC
Gate plateau voltage	$V_{plateau}$		-	3.2	-	V
Drain-Source Diode Characteristics and Maximum Ratings						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 50\text{ A}$	-	0.79	1.2	V
Reverse recovery time	T_{rr}	$I_S = 50\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	-	80	-	ns
Reverse recovery charge	Q_{rr}		-	138	-	nC
Peak Reverse Recovery Current	I_{rrm}		-	4.5	-	A

Electrical Characteristics Diagrams

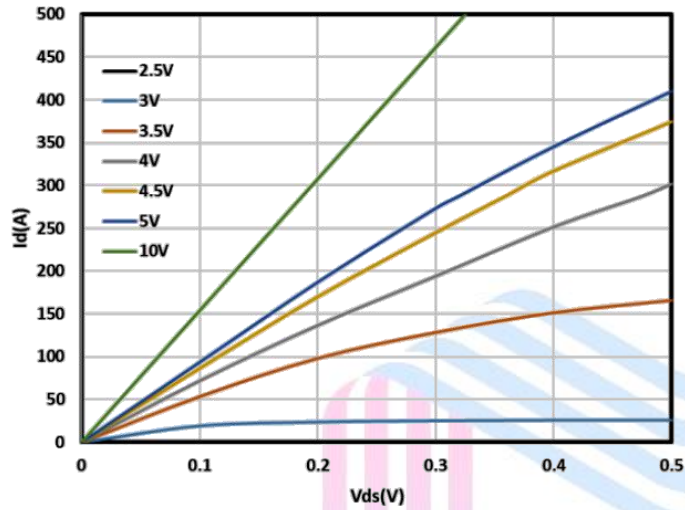
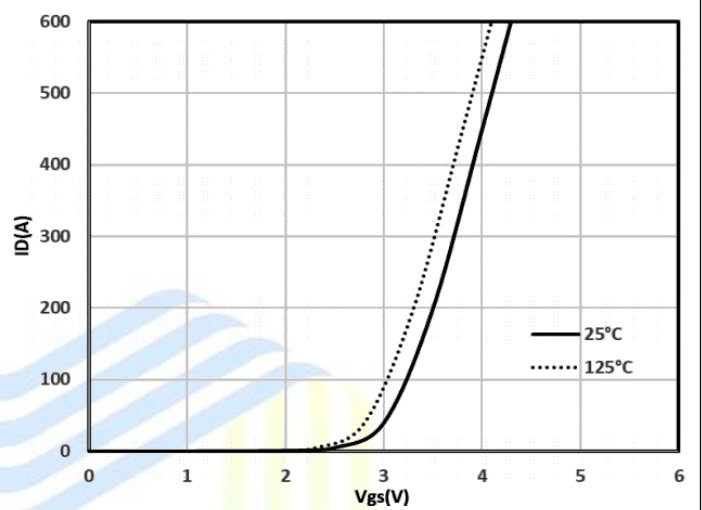
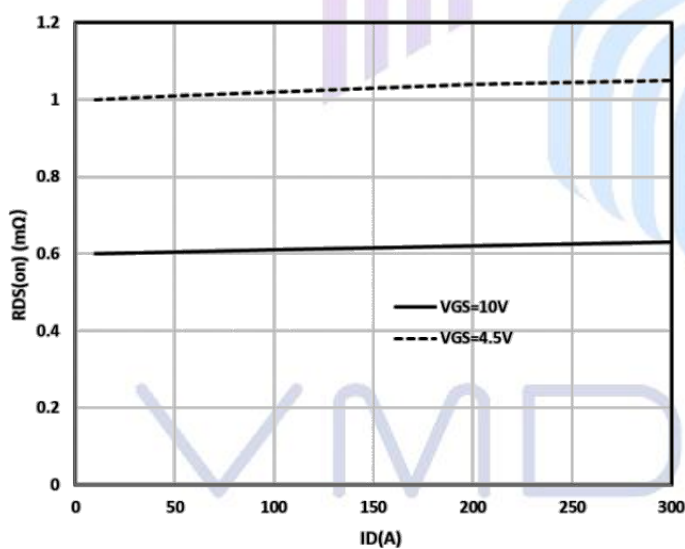
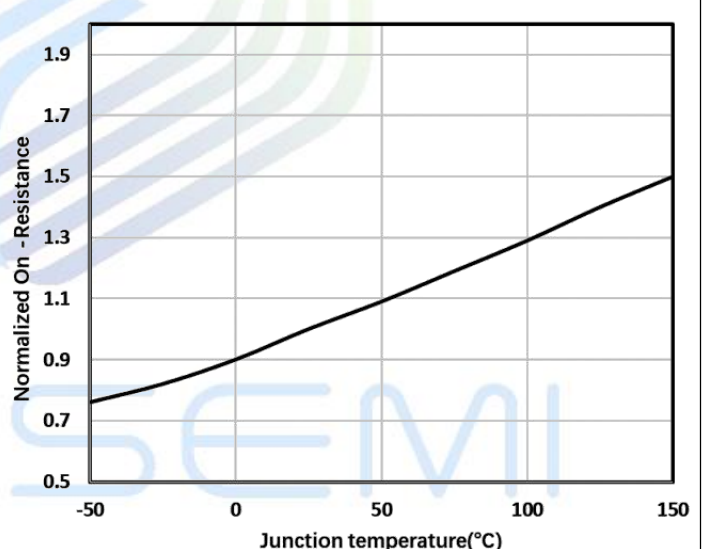
Figure 1: Typical Output Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current

Figure 4: On-Resistance vs. Junction Temperature


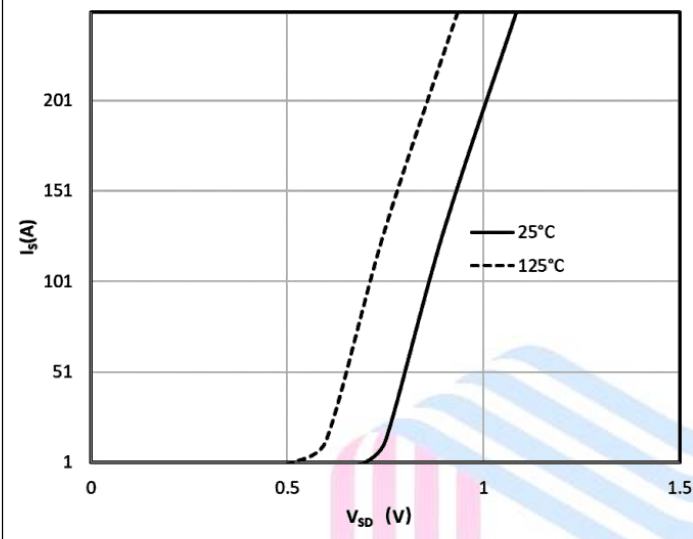
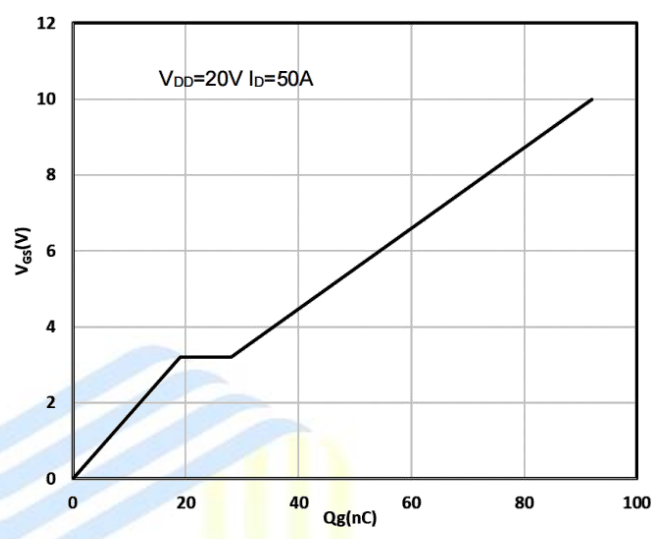
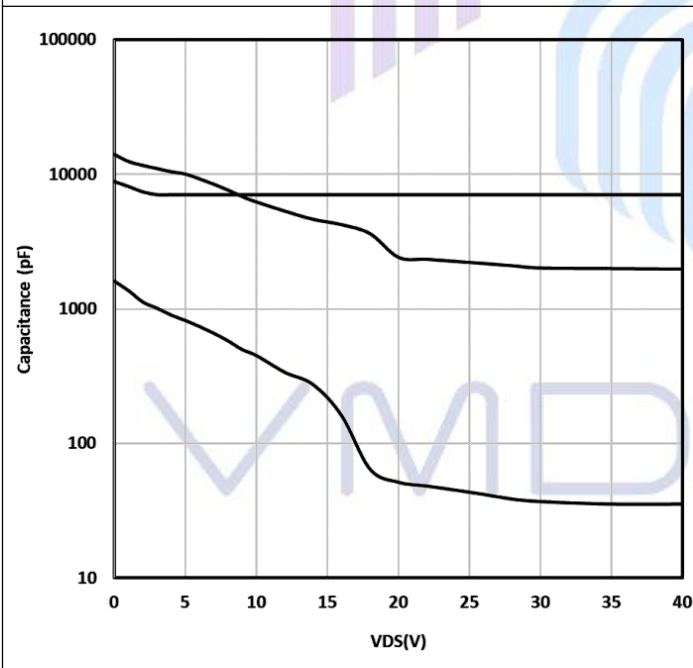
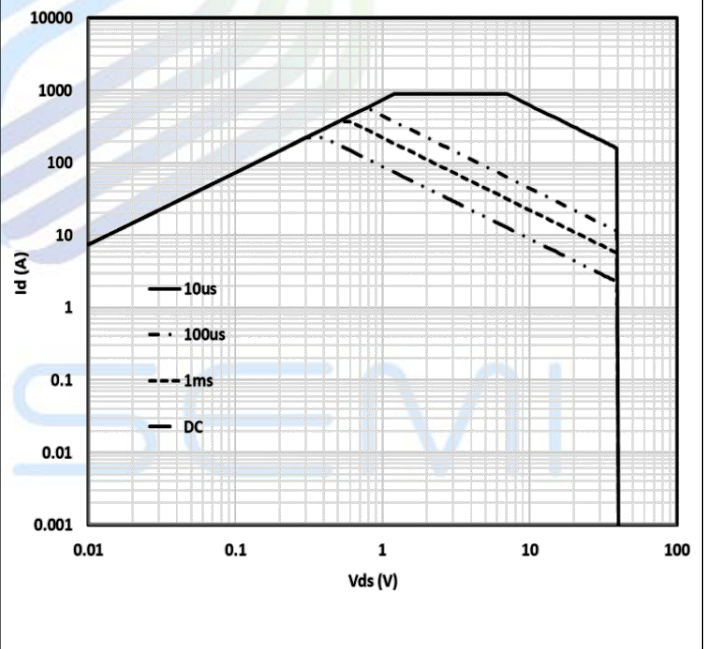
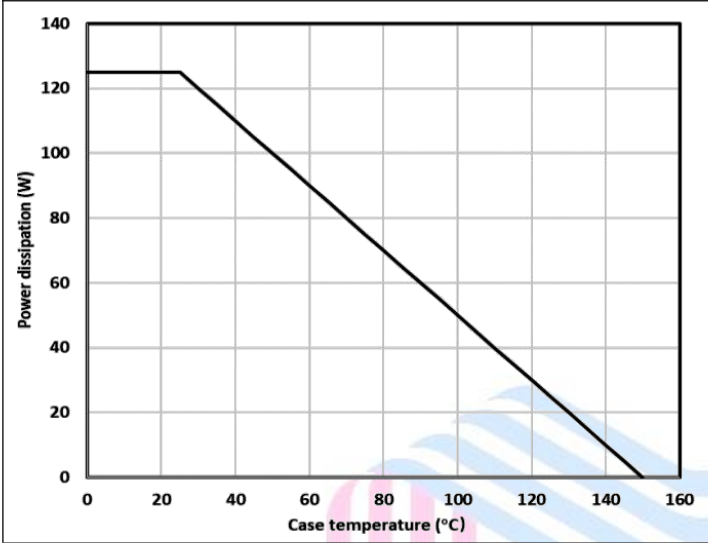
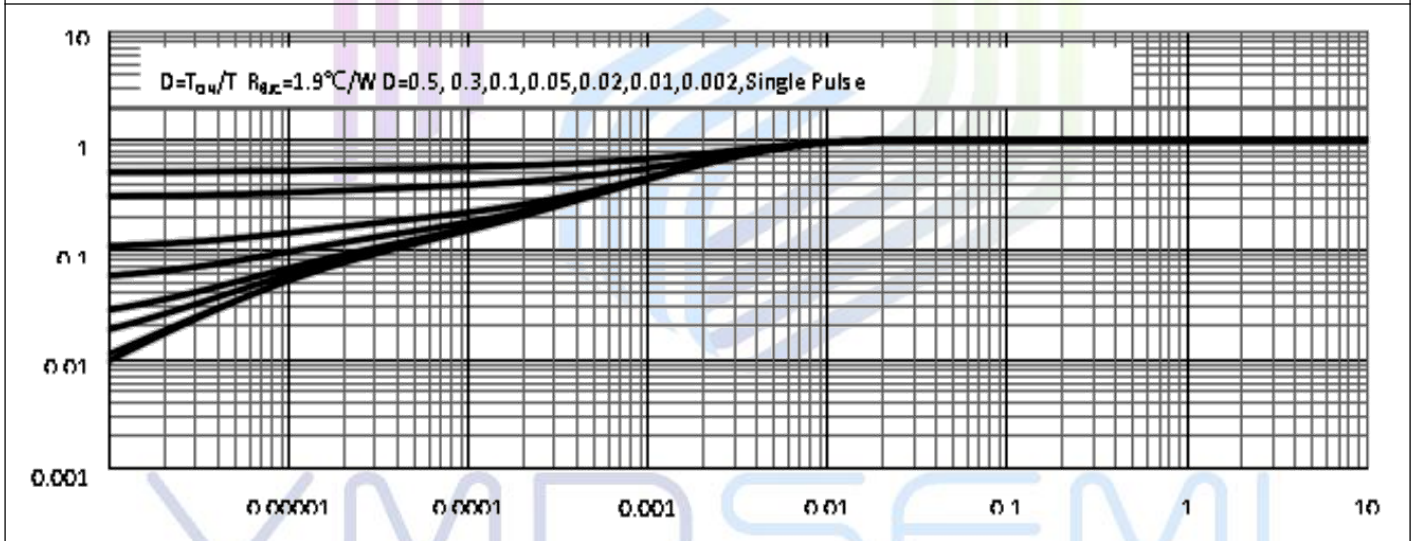
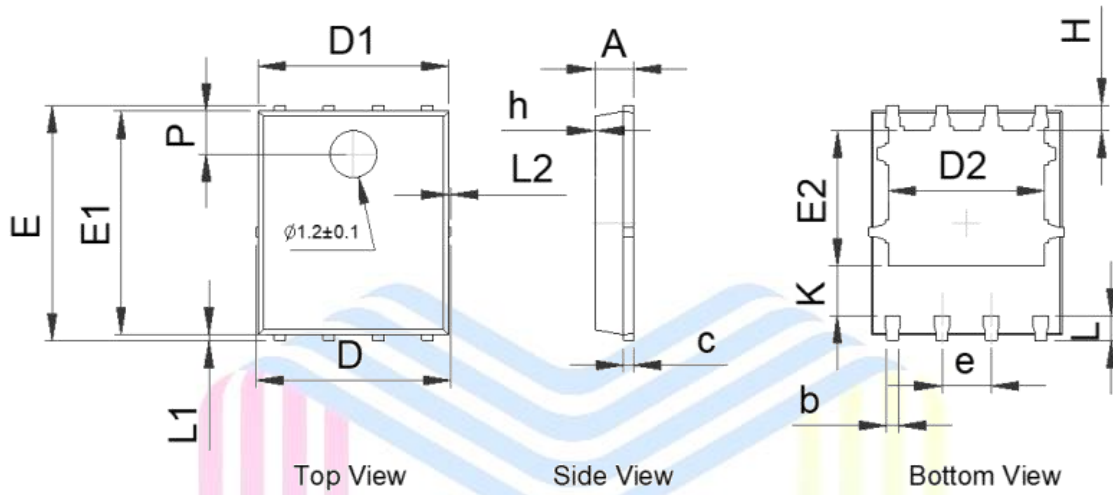
Figure 5: Forward characteristics of reverse diode

Figure 6: Gate Charge Characteristics

Figure 7: Capacitance Characteristics

Figure 8: Maximum Forward Biased Safe Operating Area


Figure 9: Power Dissipation

Figure 10: Normalized Transient thermal Impedance


Mechanical Dimensions
PDFN5x6 Package Information


SYMBOL	MIN	NOM	MAX
A	0.90	1.00	1.10
b	0.20	0.30	0.40
c	0.21	0.25	0.34
D	-	-	5.10
D1	4.80	4.90	5.00
D2	3.91	4.01	4.11
e	1.27 BSC		
E	5.90	6.00	6.10
E1	5.65	5.75	5.85
E2	3.375	3.475	3.575
H	0.55	0.65	0.75
h	-	-	0.10
K	1.20	-	-
L	0.55	0.65	0.75
L1	0.05	0.15	0.25
L2	-	-	0.12
θ	8°	10°	12°
P	1.00	1.10	1.20

Unit in mm

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